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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>09995378 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>OHNO, TOMOYUKI |
|  | <b>Examiner</b><br><br>Huynh, Son P            | <b>Art Unit</b><br><br>2623  |

| SEARCHED      |                |          |          |
|---------------|----------------|----------|----------|
| Class         | Subclass       | Date     | Examiner |
| UPDATE SEARCH |                | 11/10/06 | AH       |
| 725           | 39-41,43-44,52 | 11/10/06 | AH       |
| update search |                |          |          |
| 725           | 40-44          | 6/7/07   | AH       |

| SEARCH NOTES   |          |          |
|--|----------|----------|
| Search Notes   | Date     | Examiner |
| EAST TEXT SEARCH ENCLOSED  | 11/10/06 | AH       |
| update East text search enclosed   | 6/7/07   | AH       |
| Scott Beliveau, Michael Hoyer, Ngoc Vu, Rueben Brown (all in 725), QEM, Vivek Srivastava | 6/7/07   | AH       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |